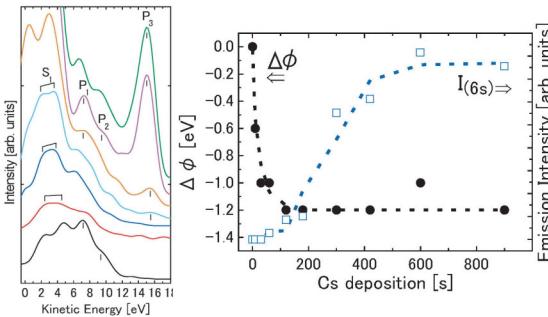
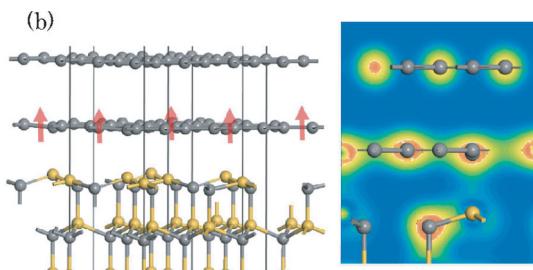


ホームページ：<http://www.sssj.org/ejssnt> 電子メール：ejssnt@sssj.orgJ-Stage アーカイブ：<http://www.jstage.jst.go.jp/browse/ejssnt/>

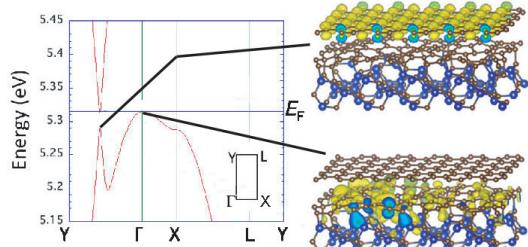
Cs吸着によるSiC結晶表面の酸化促進
Oxidation at Cs Pre-Adsorbed Si/6H-SiC(0001)-(3 × 3)
Reconstructed Surfaces Studied Using Metastable-Induced Electron Spectroscopy (Conference -ALC '15)
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Tomonori Ikari, Takuto Nakamura, Kaede Hirayama, Kousuke Muraoka, Junko Ishii, Masamichi Naitoh



バッファーレー層を含めたグラフェンの電子状態
First-Principles Calculation Study of Epitaxial Graphene Layer on 4H-SiC (0001) Surface
(Conference -ALC '15) Vol. 14, pp. 107-112 (April 2, 2016)
Junko Ishii, Shigenori Matsushima, Hiroyuki Nakamura, Tomonori Ikari, Masamichi Naitoh

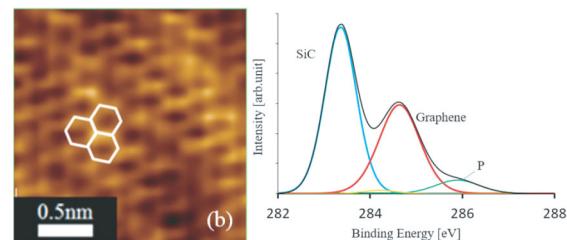


SiC(11-20)結晶表面上に形成されるグラフェン
Theoretical Study of Graphene on SiC(11-20) a-Face
(Conference -ALC '15) (April 9, 2016)
Vol. 14, pp. 113-120, Hiroyuki Kageshima, Hiroki Hibino

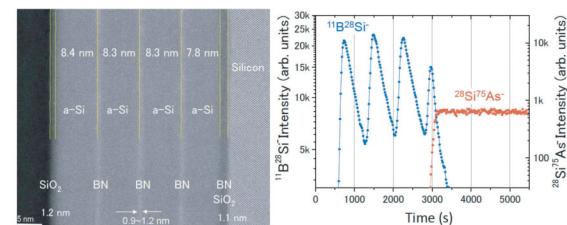


Arイオンビーム照射でグラフェンの成長を促進
Growth of Graphene on SiC(111) Surfaces via Ion-Beam Irradiation (Conference -ALC '15-)
Vol. 14, pp. 121-124 (April 9, 2016)

Junko Ishii, Yasuhiro Miyawaki, Naoya Tsuboi, Tomonori Ikari, Masamichi Naitoh



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Development of a Certified Reference Material with Delta-Doped Boron Nitride Layers for Surface Depth-Profile Analysis (Conference -ALC '15-)
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Akira Kurokawa, Yasushi Azuma, Shinya Terauchi, Toshiko Takatsuka, Tomohiro Narukawa, Akio Takano, Seiichiro Mizuno, Junichiro Sameshima



水分を含む生体試料のTOF-SIMS分析
Development of a Simple System for the Analysis of Water-Containing Biological Samples by TOF-SIMS
(Conference -ALC '15) Vol. 15, pp. 131-135 (April 16, 2016)
Keita Kanenari, Masato Morita, Tetsuo Sakamoto

